

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/507,155	HAYS, JEFFREY C		
Examiner	Art Unit		
Gerald Gauthier	2645		

SEARCHED					
Class	Subclass	Date	Examiner		
	_	,			
			-		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		** *			
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
DATE	EXMR			
2/10/2006	GG			
	DATE			